



STL11N4LLF5

N-channel 40 V, 9.1 mΩ typ., 15 A STripFET™V Power MOSFET
in a PowerFLAT™ 3.3 x 3.3 package

Datasheet – production data

Features

| Order code | V _{DS} | R _{DS(on)} max | I _D |
|-------------|-----------------|-------------------------|----------------|
| STL11N4LLF5 | 40 V | 9.7 mΩ | 15 A |

- Low gate charge
- Very low on-resistance
- High avalanche ruggedness

Applications

- Switching applications

Description

This device is an N-channel Power MOSFET developed using STMicroelectronics' STripFET™V technology. The device has been optimized to achieve very low on-state resistance, contributing to a FOM that is among the best in its class.

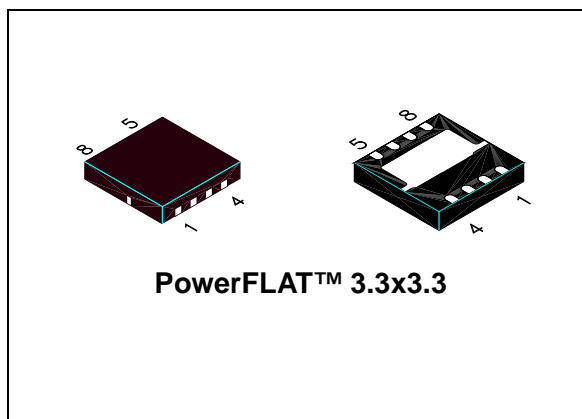


Figure 1. Internal schematic diagram

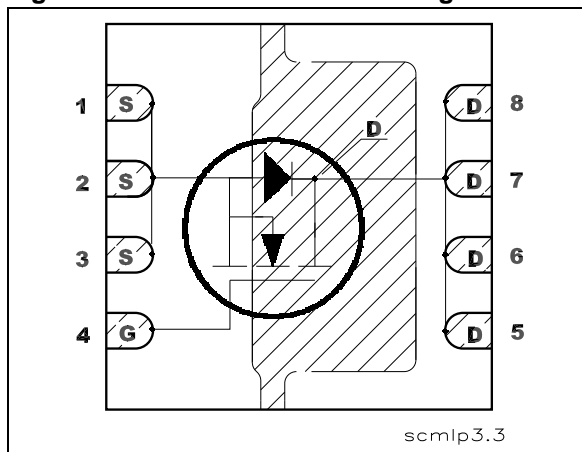


Table 1. Device summary

| Order code | Marking | Package | Packaging |
|-------------|----------|----------------------|---------------|
| STL11N4LLF5 | 11N4LLF5 | PowerFLAT™ 3.3 x 3.3 | Tape and reel |

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1 Electrical ratings

Table 2. Absolute maximum ratings

| Symbol | Parameter | Value | Unit |
|--------------------|---|------------|---------------------|
| V_{DS} | Drain-source voltage | 40 | V |
| V_{GS} | Gate-source voltage | ± 20 | V |
| $I_D^{(1)}$ | Drain current (continuous) at $T_{pcb} = 25\text{ }^\circ\text{C}$ | 11 | A |
| $I_D^{(1)}$ | Drain current (continuous) at $T_{pcb} = 100\text{ }^\circ\text{C}$ | 6.8 | A |
| $I_{DM}^{(2)}$ | Drain current (pulsed) | 44 | A |
| $P_{TOT}^{(3)}$ | Total dissipation at $T_C = 25\text{ }^\circ\text{C}$ | 50 | W |
| $P_{TOT}^{(1)}$ | Total dissipation at $T_{pcb} = 25\text{ }^\circ\text{C}$ | 2.9 | W |
| | Derating factor ⁽³⁾ | 0.4 | W/ $^\circ\text{C}$ |
| T_J T_{stg} | Operating junction temperature storage temperature | -55 to 150 | $^\circ\text{C}$ |

1. The value is rated according $R_{thj-pcb}$
2. Pulse width limited by safe operating area.
3. The value is rated according R_{thj-c}

Table 3. Thermal resistance

| Symbol | Parameter | Value | Unit |
|---------------------|----------------------------------|-------|---------------------------|
| $R_{thj-case}$ | Thermal resistance junction-case | 2.5 | $^\circ\text{C}/\text{W}$ |
| $R_{thj-pcb}^{(1)}$ | Thermal resistance junction-pcb | 42.8 | $^\circ\text{C}/\text{W}$ |
| $R_{thj-pcb}^{(2)}$ | Thermal resistance junction-pcb | 63.5 | $^\circ\text{C}/\text{W}$ |

1. When mounted on FR-4 board of 1inch² , 2oz Cu, $t < 10\text{sec}$
2. Steady state

2 Electrical characteristics

($T_{CASE}=25^{\circ}C$ unless otherwise specified)

Table 4. On/off states

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|---------------|--|---|------|-------------|-----------|------------------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage | $I_D = 250 \mu A, V_{GS} = 0$ | 40 | | | V |
| I_{DSS} | Zero gate voltage drain current ($V_{GS} = 0$) | $V_{DS} = 40 V,$ $V_{DS} = 40 V, T_C = 125^{\circ}C$ | | | 1 10 | μA μA |
| I_{GSS} | Gate body leakage current ($V_{DS} = 0$) | $V_{GS} = \pm 20 V$ | | | ± 100 | μA |
| $V_{GS(th)}$ | Gate threshold voltage | $V_{DS} = V_{GS}, I_D = 250 \mu A$ | 1 | | 2.5 | V |
| $R_{DS(on)}$ | Static drain-source on-resistance | $V_{GS} = 10 V, I_D = 5.5 A$ $V_{GS} = 4.5 V, I_D = 5.5 A$ | | 9.1 10.6 | 9.7 12 | $m\Omega$ $m\Omega$ |

Table 5. Dynamic

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------|------------------------------|--|------|------|------|----------|
| C_{iss} | Input capacitance | $V_{DS} = 25 V, f = 1 MHz,$ $V_{GS} = 0$ | | 1570 | | pF |
| C_{oss} | Output capacitance | | | 257 | | pF |
| C_{rss} | Reverse transfer capacitance | | | 32 | | pF |
| Q_g | Total gate charge | $V_{DD} = 15 V, I_D = 11 A$ | | 12.9 | | nC |
| Q_{gs} | Gate-source charge | $V_{GS} = 4.5 V$ | | 3.9 | | nC |
| Q_{gd} | Gate-drain charge | (see Figure 14) | | 5.3 | | nC |
| R_G | Gate input resistance | $f = 1 MHz$ Gate DC Bias = 0 Test signal level = 20 mV $I_D = 0$ | 0.5 | 1.5 | 2.5 | Ω |

Table 6. Switching times

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|--------------|---------------------|--|------|------|------|------|
| $t_{d(on)}$ | Turn-on delay time | $V_{DD} = 15 V, I_D = 5.5 A,$ $R_G = 4.7 \Omega, V_{GS} = 4.5 V$ (see Figure 13) | | 14 | | ns |
| t_r | Rise time | | | 42 | | ns |
| $t_{d(off)}$ | Turn-off delay time | | - | 37 | - | ns |
| t_f | Fall time | | | 5.2 | | ns |

Table 7. Source drain diode

| Symbol | Parameter | Test conditions | Min. | Typ. | Max. | Unit |
|-----------------------------------|--|---|------|---------------------|------|---------------|
| I_{SD} | Source-drain current | | - | | 11 | A |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) | | - | | 44 | A |
| $V_{SD}^{(2)}$ | Forward on voltage | $I_{SD}=11\text{ A}$, $V_{GS}=0$ | - | | 1.1 | V |
| t_{rr} Q_{rr} I_{RRM} | Reverse recovery time Reverse recovery charge Reverse recovery current | $I_{SD}=11\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$, $V_{DD}=20\text{ V}$, $T_j=150\text{ }^\circ\text{C}$ (see Figure 18) | - | 27.2 24.5 1.8 | | ns nC A |

1. Pulse width limited by safe operating area.
2. Pulsed: pulse duration=300 μs , duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

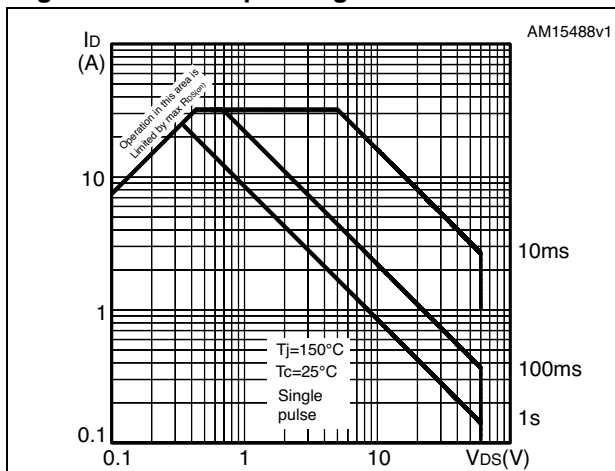


Figure 3. Thermal impedance

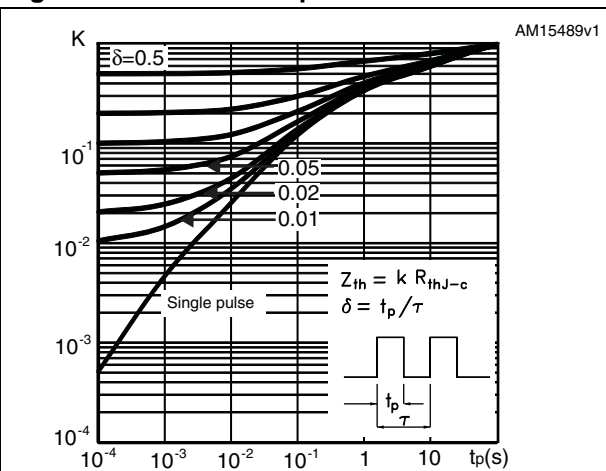


Figure 4. Output characteristics

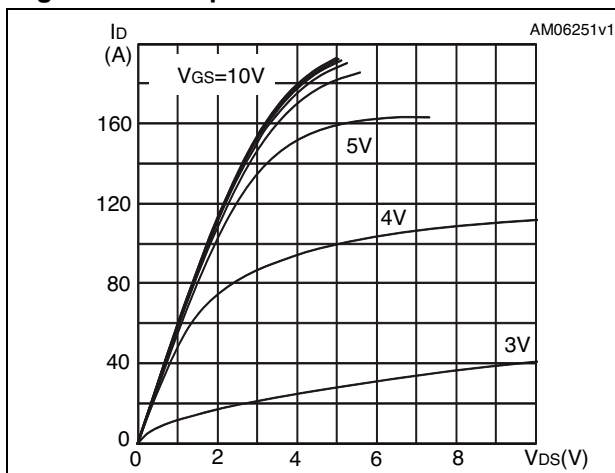


Figure 5. Transfer characteristics

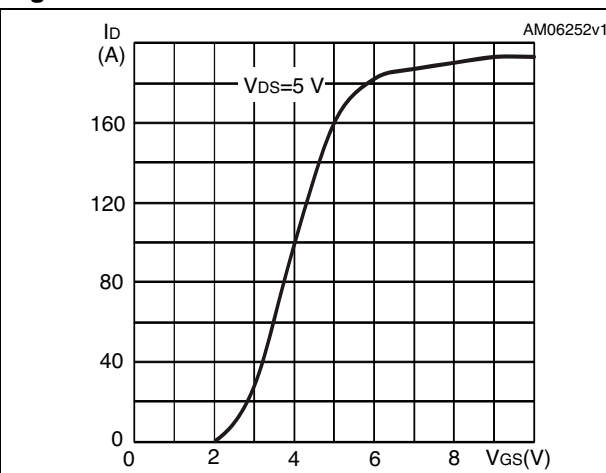


Figure 6. Normalized $B_{V_{DS}}$ vs temperature

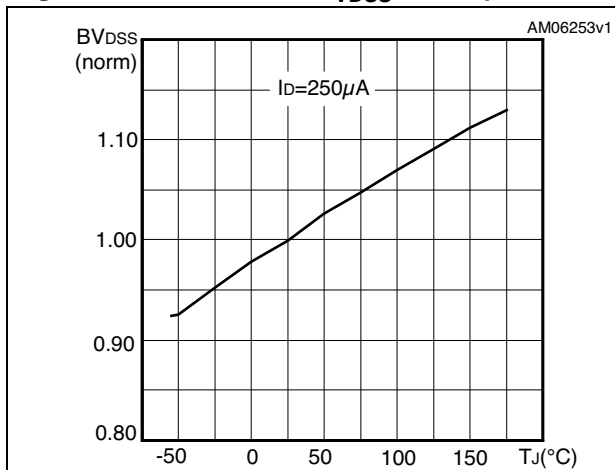


Figure 7. Static drain-source on-resistance

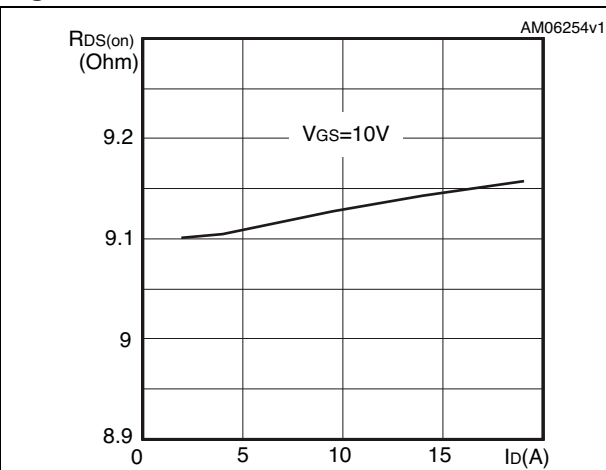


Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

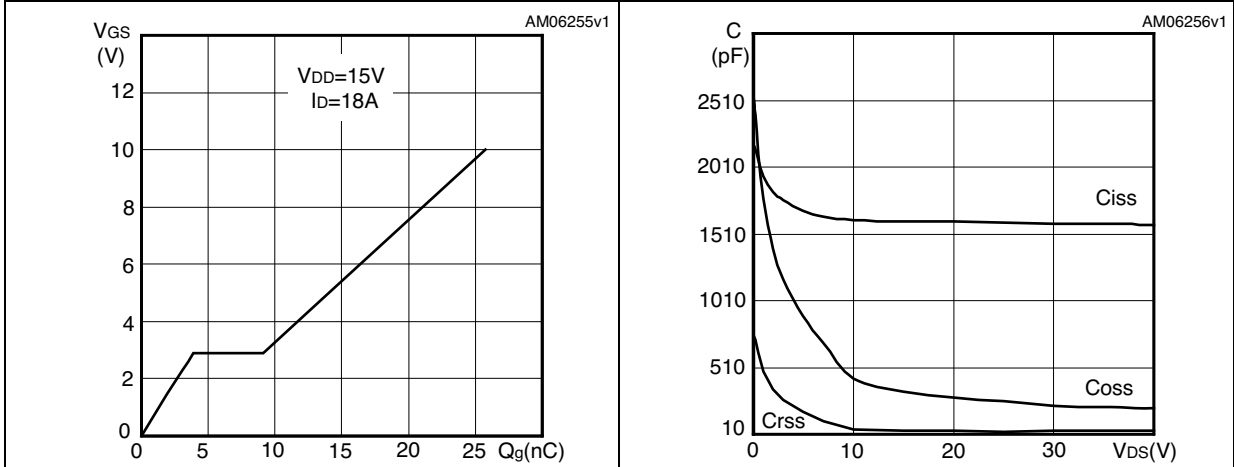


Figure 10. Normalized gate threshold voltage vs temperature Figure 11. Normalized on-resistance vs temperature

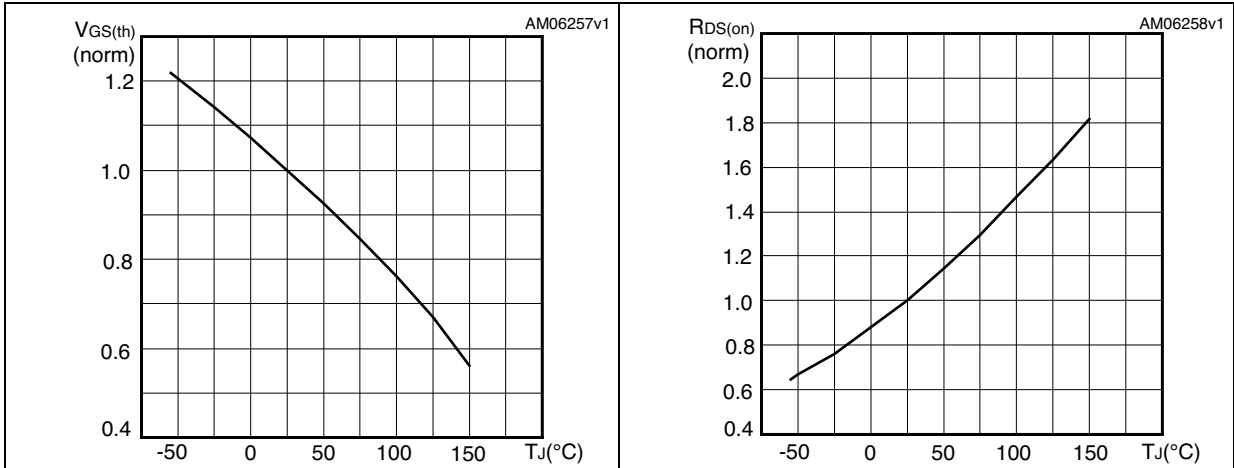
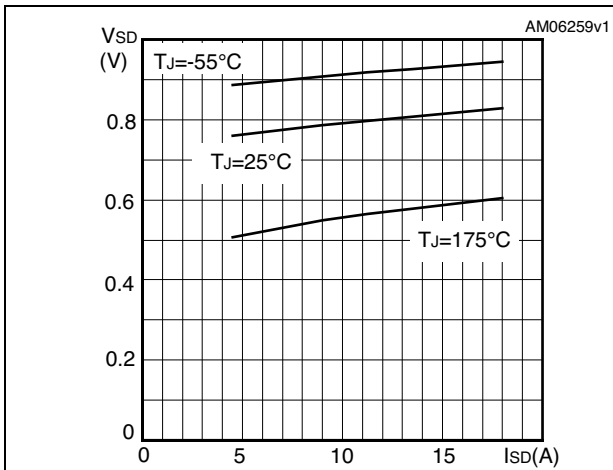
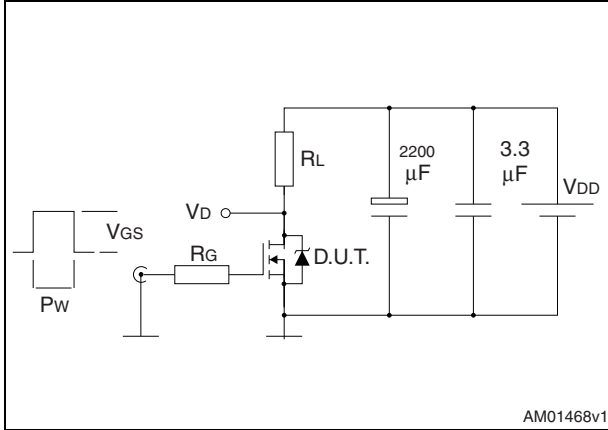


Figure 12. Source-drain diode forward characteristics



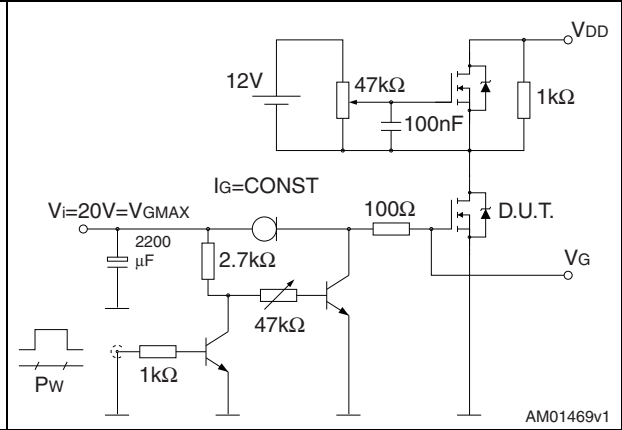
3 Test circuits

Figure 13. Switching times test circuit for resistive load



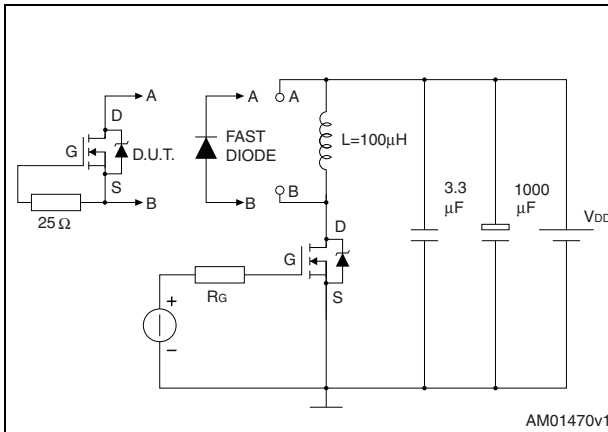
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Figure 14. Gate charge test circuit



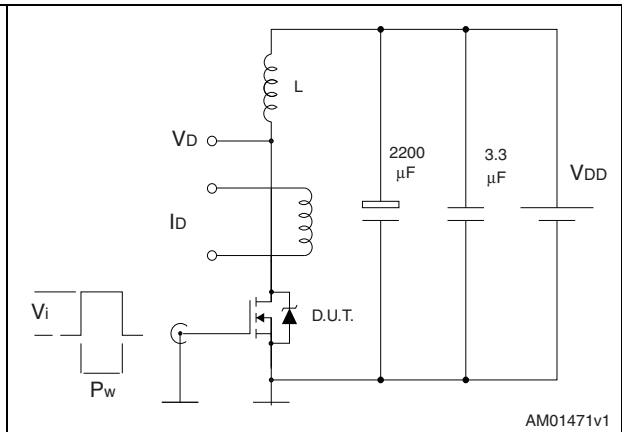
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Figure 15. Test circuit for inductive load switching and diode recovery times



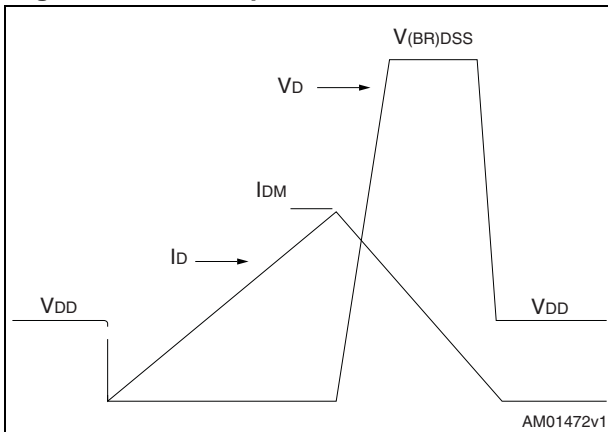
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Figure 16. Unclamped inductive load test circuit



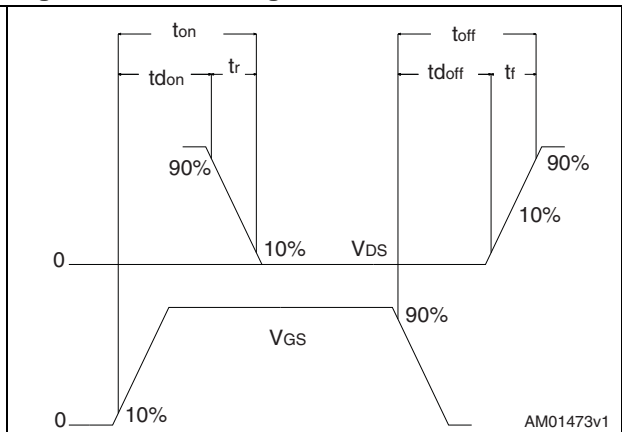
AM01471v1

Figure 17. Unclamped inductive waveform



AM01472v1

Figure 18. Switching time waveform



AM01473v1

4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK[®] is an ST trademark.

Table 8. PowerFLAT™ 3.3 x 3.3 mechanical data

| Dim. | mm | | |
|------|------|------|------|
| | Min. | Typ. | Max. |
| A | 0.80 | 0.90 | 1.00 |
| A1 | 0 | | 0.05 |
| A3 | | 0.20 | |
| b | 0.23 | | 0.38 |
| D | 3.20 | 3.30 | 3.40 |
| D2 | 2.50 | | 2.75 |
| E | 3.20 | 3.30 | 3.40 |
| E2 | 1.25 | | 1.50 |
| e | | 0.65 | |
| L | 0.30 | | 0.50 |

Figure 19. PowerFLAT™ 3.3 x 3.3 drawing

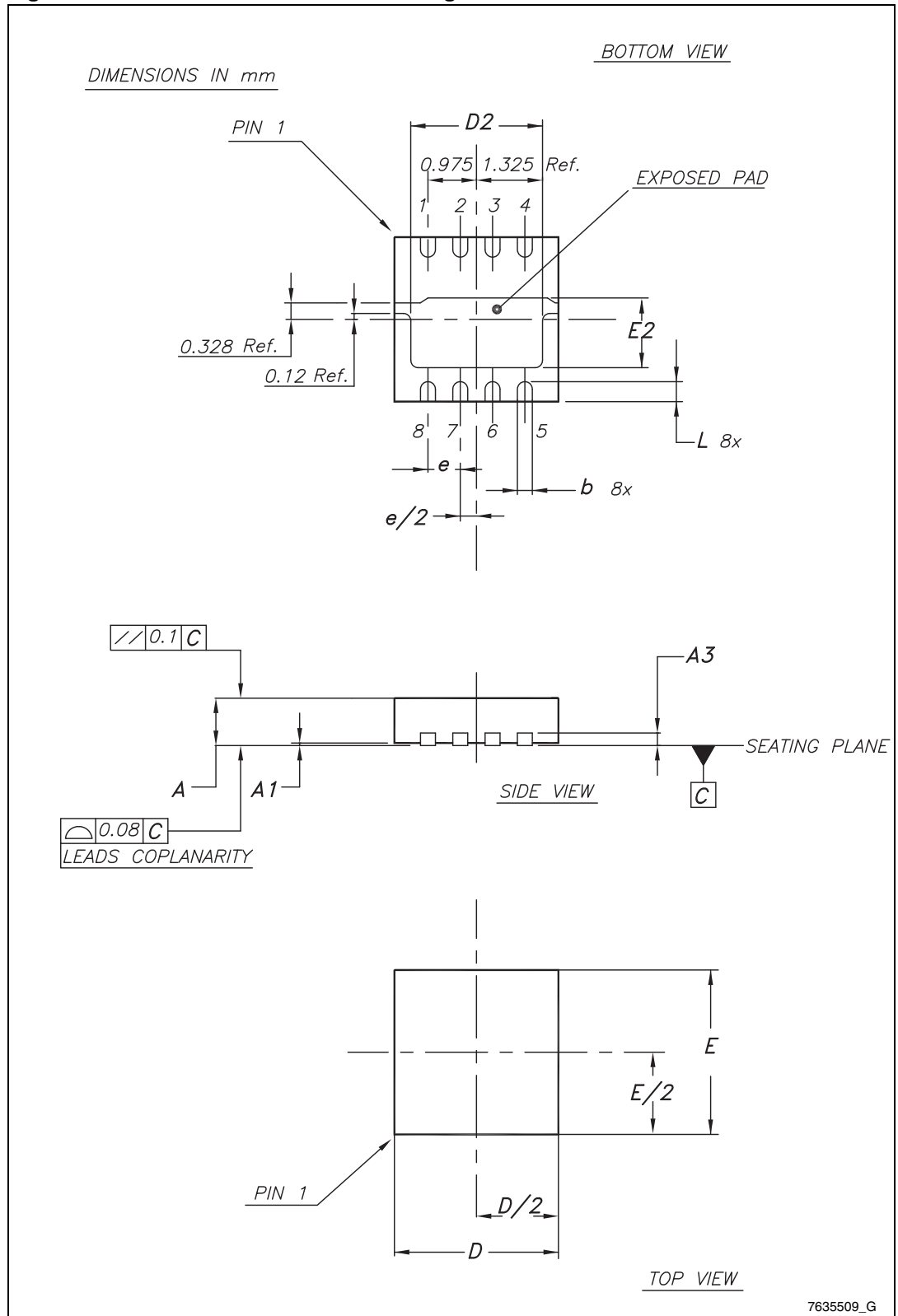
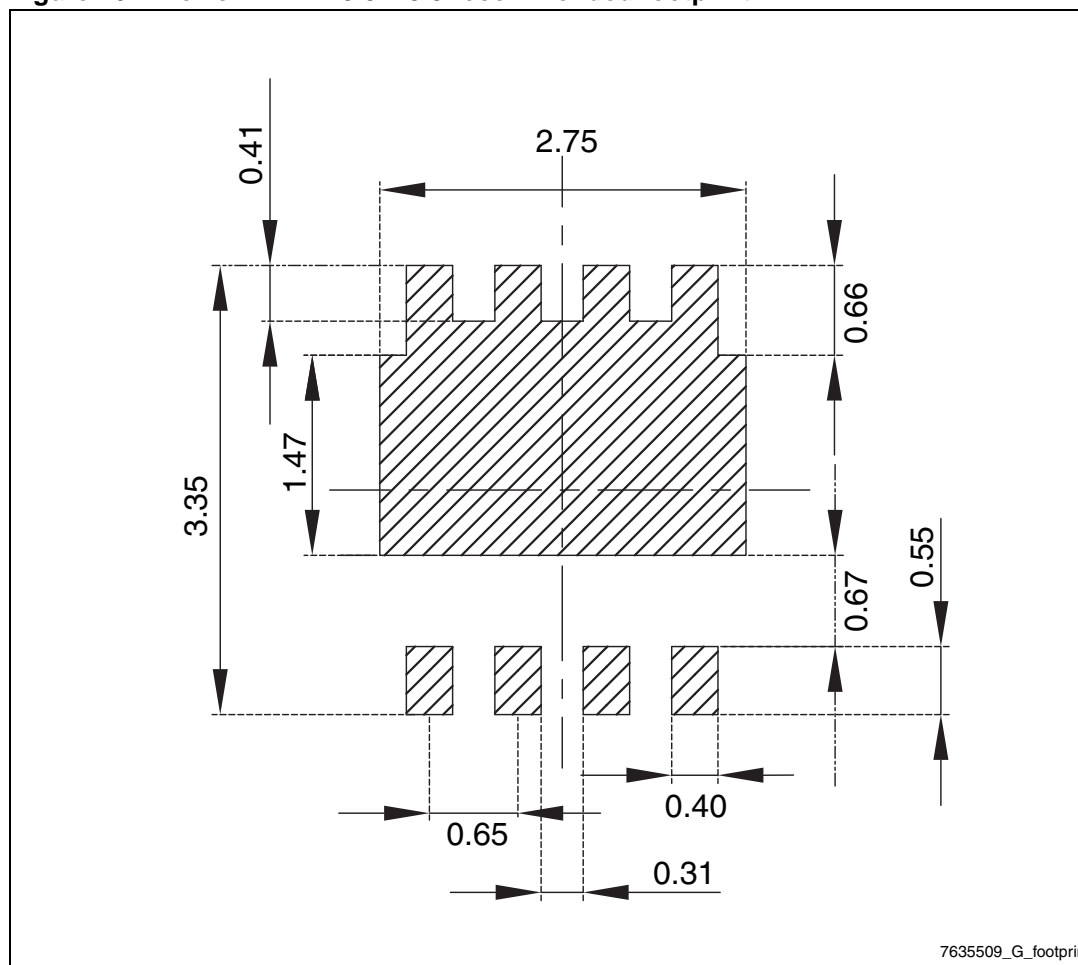


Figure 20. PowerFLAT™ 3.3 x 3.3 recommended footprint



5 Revision history

Table 9. Document revision history

| Date | Revision | Changes |
|-------------|----------|---------------|
| 19-Feb-2013 | 1 | First release |

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